

N-Channel Power MOSFET

30V, 124A, 3.6mΩ

FEATURES

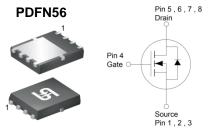
- Low R_{DS(ON)} to minimize conductive losses
- Low gate charge for fast power switching
- 100% UIS and R_q tested
- Compliant to RoHS directive 2011/65/EU and in accordance to WEEE 2002/96/EC
- Halogen-free according to IEC 61249-2-21

KEY PERFORMANCE PARAMETERS				
PARAMETER		VALUE	UNIT	
V _D	S	30	V	
R _{DS(on)} (max)	V _{GS} = 10V	3.6	0	
	$V_{GS} = 4.5V$	5.5	mΩ	
Q_g		25	nC	

APPLICATIONS

- DC-DC Converters
- Battery Power Management
- ORing FET/Load Switch





Note: MSL 1 (Moisture Sensitivity Level) per J-STD-020

ABSOLUTE MAXIMUM RATINGS (T _A = 25°C unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V_{DS}	30	V	
Gate-Source Voltage		V_{GS}	±20	V	
Continuous Drain Current (Note 1)	$T_C = 25^{\circ}C$	I _D	124	Δ.	
	$T_C = 25^{\circ}C$ $T_A = 25^{\circ}C$		22	_ A	
Pulsed Drain Current		I _{DM}	496	А	
Single Pulse Avalanche Current (Note 2)		I _{AS}	27	А	
Single Pulse Avalanche Energy (Note 2)		E _{AS}	109	mJ	
Total Power Dissipation	$T_C = 25^{\circ}C$	P _D	83	W	
	$T_C = 125$ °C		17	VV	
Total Power Dissipation	$T_A = 25$ °C	Б	2.6	10/	
	$T_A = 125^{\circ}C$	P _D	0.5	W	
Operating Junction and Storage Temperature Range		T _J , T _{STG}	- 55 to +150	°C	

THERMAL PERFORMANCE				
PARAMETER	SYMBOL	LIMIT	UNIT	
Junction to Case Thermal Resistance	$R_{\Theta JC}$	1.5	°C/W	
Junction to Ambient Thermal Resistance	$R_{\Theta JA}$	48	°C/W	

Thermal Performance Note: $R_{\Theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistances. The case-thermal reference is defined at the solder mounting surface of the drain pins. $R_{\Theta JA}$ is guaranteed by design while $R_{\Theta CA}$ is determined by the user's board design.

1



ELECTRICAL SPECIFICATIONS (T _A = 25°C unless otherwise noted)						
PARAMETER	CONDITIONS	SYMBOL	MIN	TYP	MAX	UNIT
Static						
Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	BV _{DSS}	30			V
Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	$V_{GS(TH)}$	1.2	1.6	2.5	V
Gate-Source Leakage Current	$V_{GS} = \pm 20 V, V_{DS} = 0 V$	I _{GSS}			±100	nA
	$V_{GS} = 0V, V_{DS} = 30V$	I _{DSS}			1	μA
Drain-Source Leakage Current	$V_{GS} = 0V, V_{DS} = 30V$ $T_{J} = 125^{\circ}C$				100	
Drain-Source On-State Resistance	$V_{GS} = 10V, I_D = 22A$	_		3	3.6	mΩ
(Note 3)	$V_{GS} = 4.5V, I_D = 22A$	R _{DS(on)}		4	5.5	
Forward Transconductance (Note 3)	$V_{DS} = 5V, I_{D} = 22A$	g _{fs}		44		S
Dynamic (Note 4)						
Total Gate Charge	$V_{GS} = 10V, V_{DS} = 15V,$ $I_{D} = 22A$	Q_g		50		
Total Gate Charge	V _{GS} = 4.5V, V _{DS} = 15V,	Q_g		25		nC
Gate-Source Charge		Q _{gs}		7.3		1
Gate-Drain Charge	I _D = 22A	Q_{gd}		12		
Input Capacitance		C _{iss}		2530		
Output Capacitance	$V_{GS} = 0V, V_{DS} = 15V$	C _{oss}		376		pF
Reverse Transfer Capacitance	f = 1.0MHz	C _{rss}		249		
Gate Resistance	f = 1.0MHz, open drain	R_g	0.4	1.3	2.6	Ω
Switching (Note 4)						
Turn-On Delay Time		t _{d(on)}		4.8		
Turn-On Rise Time	$V_{GS} = 10V, V_{DS} = 15V,$ $I_D = 22A, R_G = 2\Omega,$	t _r		10.4		
Turn-Off Delay Time		t _{d(off)}		25.2		ns
Turn-Off Fall Time		t _f		10.6		
Source-Drain Diode						
Forward Voltage (Note 3)	$V_{GS} = 0V, I_{S} = 22A$	V_{SD}			1	V
Reverse Recovery Time	I _S = 22A ,	t _{rr}		30		ns
Reverse Recovery Charge	dl/dt = 100A/µs	Q _{rr}		13		nC

Notes:

- 1. Silicon limited current only.
- 2. L = 0.3mH, $V_{GS} = 10$ V, $V_{DD} = 25$ V, $R_G = 25\Omega$, $I_{AS} = 27$ A, Starting $T_J = 25$ °C
- 3. Pulse test: Pulse Width \leq 300 μ s, duty cycle \leq 2%.
- 4. Switching time is essentially independent of operating temperature.

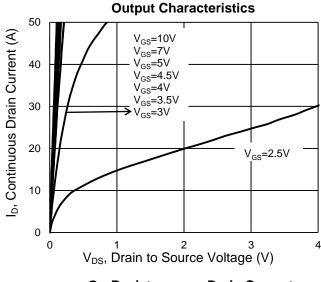
ORDERING INFORMATION

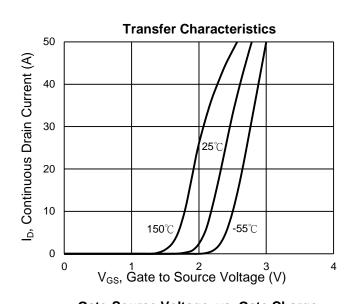
PART NO.	PACKAGE	PACKING
TSM036N03PQ56 RLG	PDFN56	2,500pcs / 13" Reel

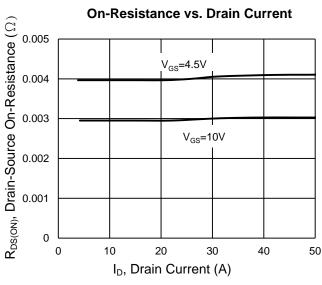


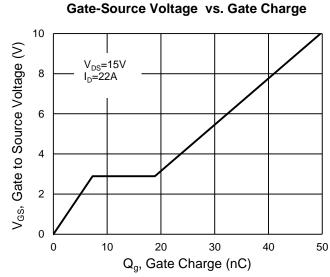
CHARACTERISTICS CURVES

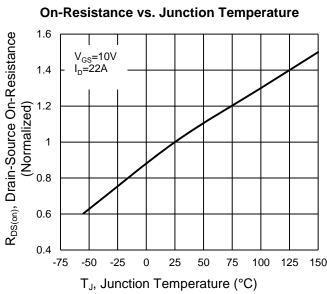
 $(T_A = 25^{\circ}C \text{ unless otherwise noted})$

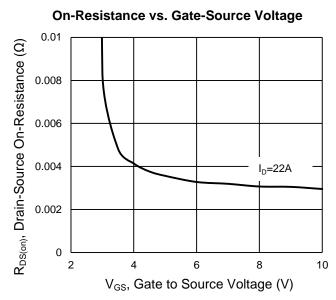












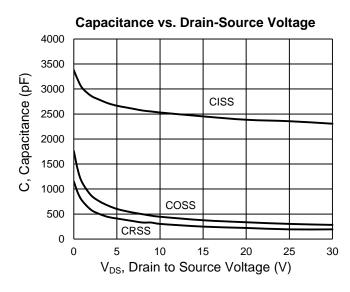
Version: B1607

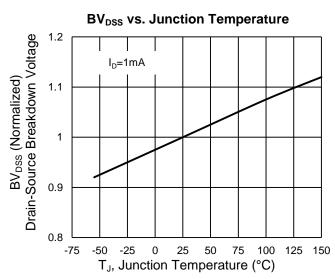
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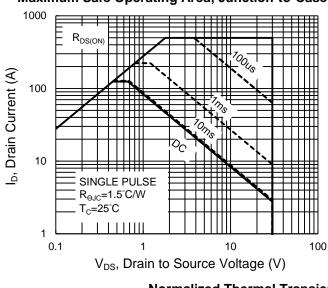
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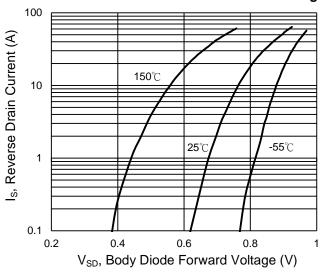




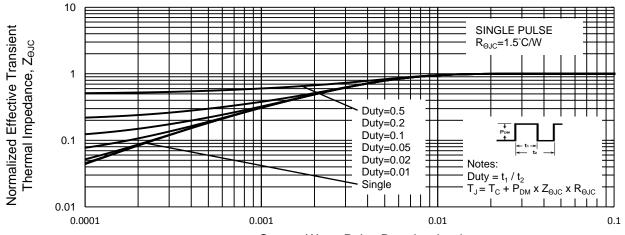
Maximum Safe Operating Area, Junction-to-Case



Source-Drain Diode Forward Current vs. Voltage



Normalized Thermal Transient Impedance, Junction-to-Case



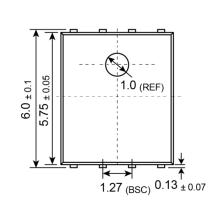
t, Square Wave Pulse Duration (sec)

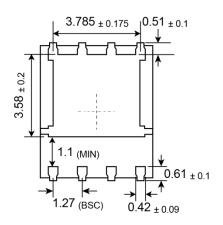


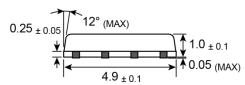
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PACKAGE OUTLINE DIMENSIONS (Unit: Millimeters)

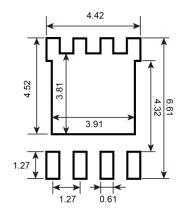
PDFN56







SUGGESTED PAD LAYOUT (Unit: Millimeters)



5

MARKING DIAGRAM



G = Halogen Free

Y = Year Code

WW = Week Code (01~52)

F = Factory Code



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